# MOSFET - Power, N-Channel, SUPERFET® III, FAST

650 V, 40 mΩ, 62 A

# NTH4LN040N65S3H

#### **Description**

SUPERFET III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provides superior switching performance, and withstand extreme dv/dt rate.

Consequently, SUPERFET III MOSFET FAST series is very suitable for the various power systems for miniaturization and higher efficiency.

#### **Features**

- 700 V @  $T_J = 150$ °C
- Typ.  $R_{DS(on)} = 32 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 132 nC)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 1267 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

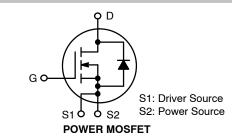
- Telecom / Server Power Supplies
- Industrial Power Supplies
- UPS / Solar



#### ON Semiconductor®

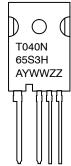
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V <sub>DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
650 V	40 mΩ @ 10 V	62 A





#### **MARKING DIAGRAM**



A = Assembly Plant Code YWW = Data Code (Year & Week)

T040N65S3H = Specific Device Code

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

### **ABSOLUTE MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ , Unless otherwise noted)

Symbol	Parameter	Value	Unit	
$V_{DSS}$	Drain to Source Voltage	650	V	
$V_{GSS}$	Gate to Source Voltage	- DC	±30	V
		- AC (f > 1 Hz)	±30	
I <sub>D</sub>	Drain Current	– Continuous (T <sub>C</sub> = 25°C)	62	Α
		- Continuous (T <sub>C</sub> = 100°C)	39	
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)	174	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)	675	mJ	
I <sub>AS</sub>	Avalanche Current (Note 2)	8.2	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)	3.79	mJ	
dv/dt	MOSFET dv/dt	120	V/ns	
	Peak Diode Recovery dv/dt (Note 3)		20	
$P_{D}$	Power Dissipation	(T <sub>C</sub> = 25°C)	379	W
		- Derate Above 25°C	3.03	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8"	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive rating: pulse width limited by maximum junction temperature. 
  2.  $I_{AS}=8.2$  A,  $R_{G}=25$   $\Omega$ , starting  $T_{J}=25^{\circ}C$ . 
  3.  $I_{SD}\leq 31$  A, di/dt  $\leq 200$  A/ $\mu$ s,  $V_{DD}\leq 400$  V, starting  $T_{J}=25^{\circ}C$ .

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.33	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	

#### PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
NTH4LN040N65S3H	T040N65S3H	TO-247 L4 Narrow Lead	Tube	N/A	N/A	30 Units

## **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
OFF CHARACT	ERISTICS			•		
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_D = 1 \text{ mA, } T_J = 25^{\circ}\text{C}$	650	-	-	V
		V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA, T <sub>J</sub> = 150°C	700	_	-	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 10 mA, Referenced to 25°C	-	0.63	_	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V	-	-	3	μΑ
		V <sub>DS</sub> = 520 V, T <sub>C</sub> = 125°C	-	2.6	_	
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA
ON CHARACTE	RISTICS					•
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 6.8 \text{ mA}$	2.4	-	4.0	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 31 A	-	32	40	mΩ
9FS	Forward Transconductance	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 31 A	-	85	-	S
DYNAMIC CHAI	RACTERISTICS					•
C <sub>iss</sub>	Input Capacitance		-	6513	-	pF
Coss	Output Capacitance	$V_{DS} = 400 \text{ V}, V_{GS} = 0 \text{ V}, f = 250 \text{ kHz}$	-	97	-	pF
C <sub>oss(eff.)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V	-	1267	-	pF
C <sub>oss(er.)</sub>	Energy Related Output Capacitance	V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V	-	170	-	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10 V		-	132	-	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	V <sub>DS</sub> = 400 V, I <sub>D</sub> = 31 A, V <sub>GS</sub> = 10 V (Note 4)	-	36	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	(1313.)	-	34	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	0.7	-	Ω
SWITCHING CH	ARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time		-	39	_	ns
t <sub>r</sub>	Turn-On Rise Time	V <sub>DD</sub> = 400 V, I <sub>D</sub> = 31 A,	-	9	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V, R}_{g} = 2.2 \Omega$ (Note 4)	-	95	-	ns
t <sub>f</sub>	Turn-Off Fall Time		-	2.8	-	ns
SOURCE-DRAII	N DIODE CHARACTERISTICS					•
I <sub>S</sub>	Maximum Continuous Source to Drain Diode Forward Current			_	62	Α
I <sub>SM</sub>	Maximum Pulsed Source to Drain Diode Forward Current		-	-	174	Α
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 31 A	-	-	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 31 A,	-	503	_	ns
Q <sub>rr</sub>	Reverse Recovery Charge	dl <sub>F</sub> /dt = 100 A/μs	_	11.4	_	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

#### TYPICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted)

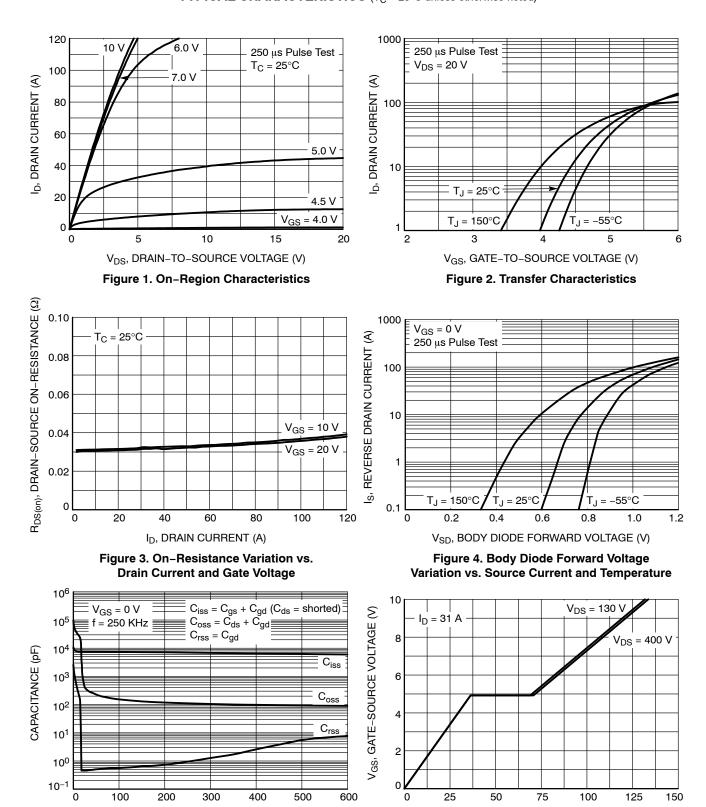


Figure 5. Capacitance Characteristics

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

#### TYPICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted)

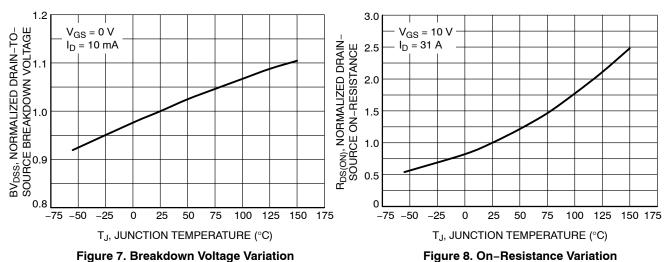


Figure 7. Breakdown Voltage Variation vs. Temperature

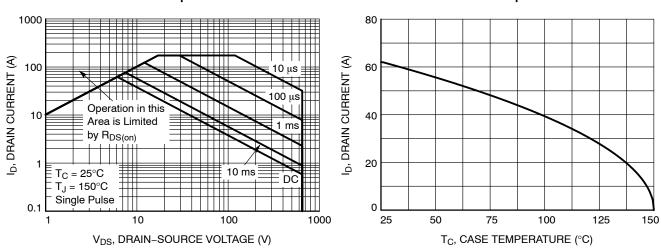


Figure 9. Maximum Safe Operating Area

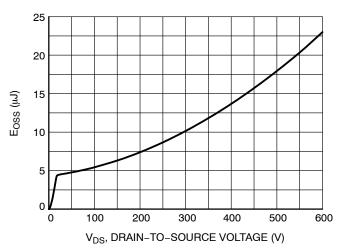


Figure 11. E<sub>OSS</sub> vs. Drain to Source Voltage

Figure 10. Maximum Drain Current vs. Case Temperature

vs. Temperature

## TYPICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted)

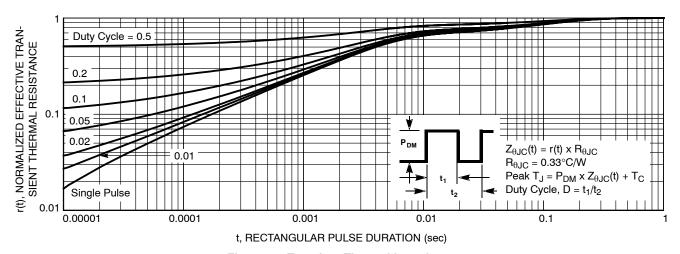


Figure 12. Transient Thermal Impedance

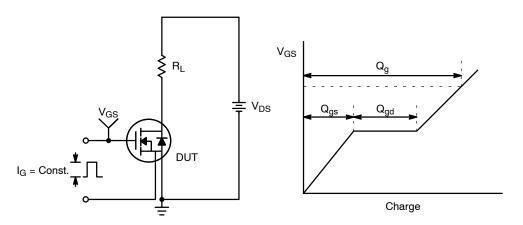


Figure 13. Gate Charge Test Circuit & Waveform

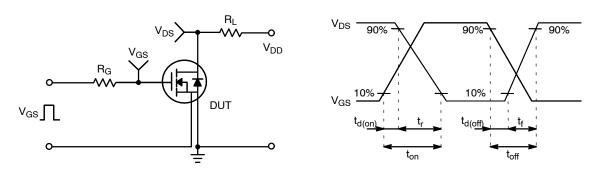


Figure 14. Resistive Switching Test Circuit & Waveforms

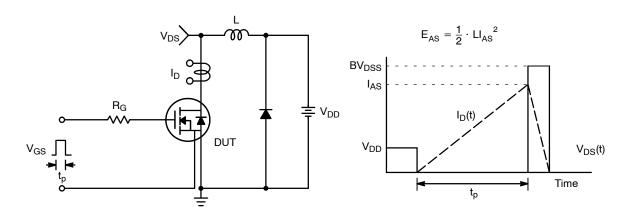


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

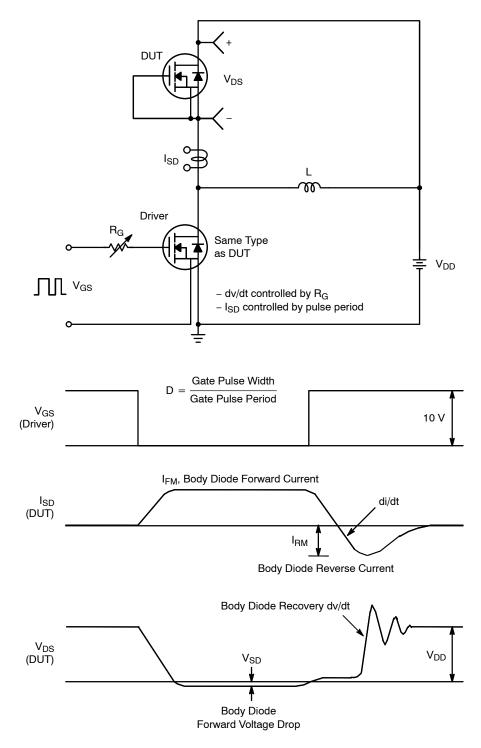
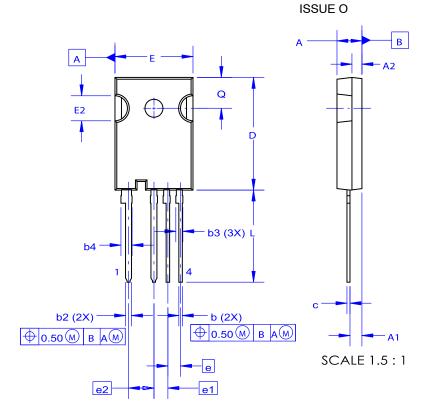


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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#### **PACKAGE DIMENSIONS**

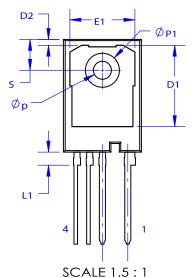
## TO-247 4-LEAD, THIN LEADS CASE 340CW



SCALE 1.5:1

#### NOTES:

- A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
- **B. DIMENSIONS ARE EXCLUSIVE OF** BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.



DIM	MILLIMETERS				
DIM	MIN NOM		MAX		
Α	4.80	5.00	5.20		
A1	1.90	2.40	2.90		
A2	1.80	2.00	2.20		
b	0.57	0.70	0.83		
b2	1.07	1.20	1.33		
b3	1.20	1.40	1.60		
b4	2.02	2.22	2.42		
С	0.50	0.60	0.70		
D	22.34	22.54	22.74		
D1	16.00	16.30	16.50		
D2	0.97	1.17	1.37		
е		2.54			
e1		2.79			
e2		5.08			
Е	15.40	15.60	15.80		
E1	12.80	13.00	13.20		
E2	4.80	5.00	5.20		
L	18.12	18.42	18.72		
L1	2.42	2.62	2.82		
Øр	3.40	3.60	3.80		
ØP1	6.60	6.80	7.00		
Q	5.97	6.17	6.37		
S	5.97	6.17	6.37		

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